## Notice of References Cited Application/Control No. 10/507,023 Applicant(s)/Patent Under Reexamination VAN DER HEIJDEN, EDGAR I Examiner Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,137,531	11-2006	Arghyris et al.	222/94
*	В	US-6,758,411	07-2004	Conway et al.	239/303
*	С	US-7,021,499	04-2006	Hansen et al.	222/145.5
*	D	US-6,726,016	04-2004	Chen, Sin-Hsiung	206/581
*	E	US-6,672,483	01-2004	Roy, Christophe	222/145.1
*	F	US-6,082,588	07-2000	Markey et al.	222/137
*	G	US-7,195,135	03-2007	Garcia et al.	222/137
*	н	US-5,356,040	10-1994	Reggiani, Fulvio	222/129
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р	•				
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>V</b>	
	w	
	x	

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